

# Resilient Dynamic Power Management under Uncertainty

Hwisung Jung and Massoud Pedram

University of Southern California  
Dept. of Electrical Engineering



# Overview

- **Introduction**
- **Stochastic Decision Making Framework**
- **Resilient Dynamic Power Management**
- **Experimental Results**
- **Conclusion**

# Introduction

- **PVT variations pose a major challenge**
  - Design of reliable systems
  - Robustness of DPM techniques
- **Stress/aging results in unacceptable safety margins**
  - Stress (HCI, NBTI, TDDB) changes  $V_{th}$  of Trans.
  - Trans. characteristics change  $> 10\%$  over 10 years
- **Lack of proper modeling and optimization tools**
  - Transforms low-level variability into system-level uncertainty
- **Improving accuracy and robustness of the decision making strategy**
  - Important step to guarantee the quality of DPM solutions

# Some Relevant Prior Work

- **S. Borkar, et al. (DAC 2003)**
  - Parameter variations and impact on architecture
- **K. Kang, et al. (DAC 2007)**
  - Variation resilient circuit design technique
- **H. Su, et al. (ISLPED 2003)**
  - Leakage estimation under V & T variations
- **M. Lie, et al. (ISLPED 2004)**
  - Probabilistic analysis for impact of variations
- **F. Marc, et al. (Trans. On Device Reliability 2006)**
  - Circuit aging simulation technique based on behavioral model

# High Level Explanation of the Problem

- **Many researchers have examined techniques for:**
  - **Variability modeling and control at the low levels (e.g., physical design optimization and/or logic synthesis)**
  - **Dynamic power management with system variables being**
    - **Directly observable**
    - **Deterministic**
- **These techniques suffer from the following:**
  - **System state is not fully observable**
  - **Conventional DPM approaches tend to be less effective because uncertainty modeling is not done**

# Overview of the Proposed Solution

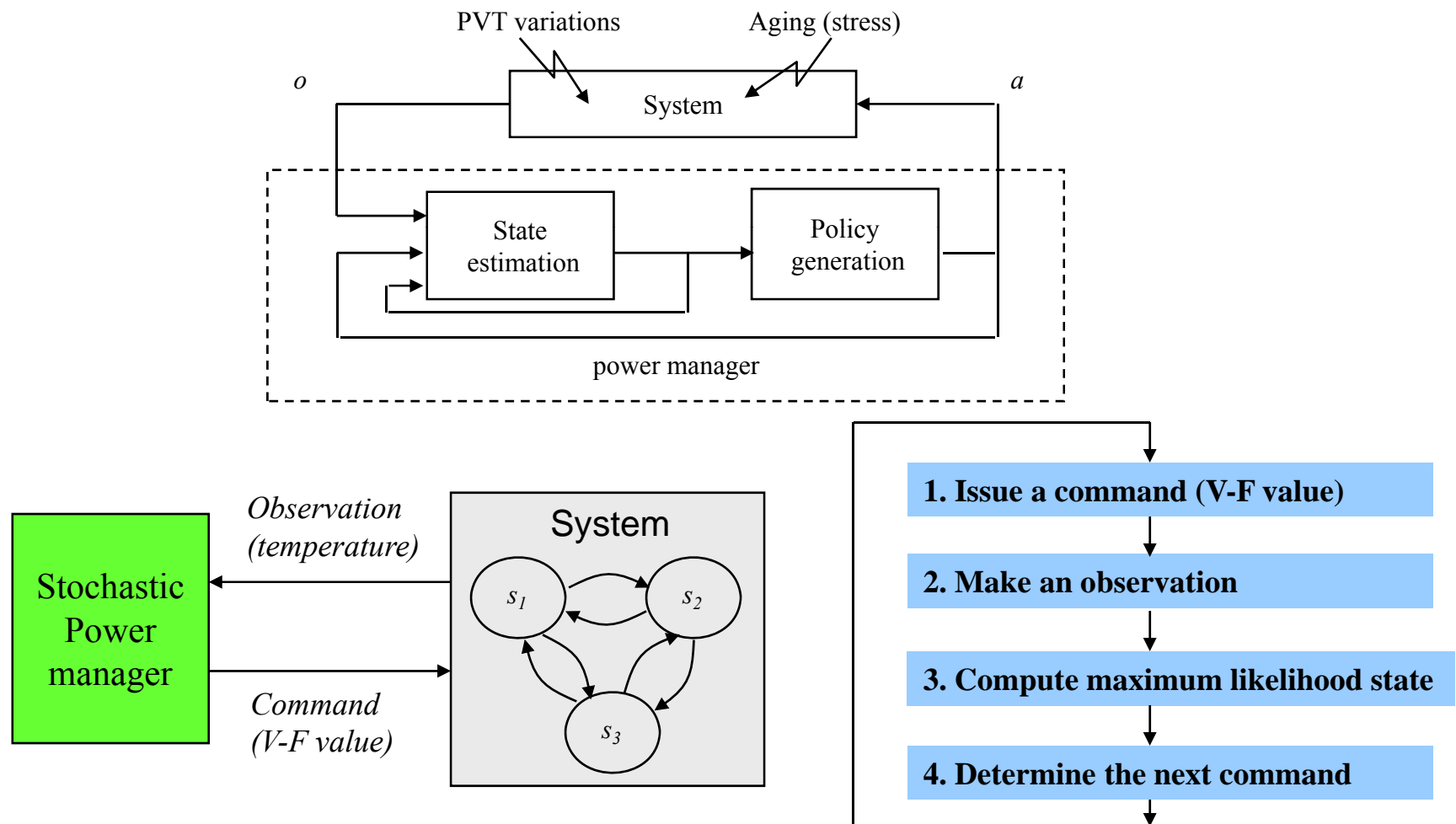
- **Develop a resilient power management framework**
  - The framework accounts for parameter variations during power management
  - Effects of uncertainties due to variability/stress are captured by stochastic processes
- **Our proposed DPM framework is based on:**
  - Stochastic process model
  - Dynamic programming
  - Expectation-maximization algorithm
    - Enables a power manager to predict uncertain state of a system in a dynamic environment
- **Roles of the power manager**
  - Interact with uncertain stochastic environments
  - Select appropriate actions (i.e., V-F values)
  - Minimize the long term cost (i.e., energy dissipation)

# POMDP

- **POMDP is a tuple  $(S, A, O, T, Z, c)$  such that**
  - **S is a finite set of states (power)**
  - **A is a finite set of actions (V-F value)**
  - **O is a finite set of observations (temperature)**
  - **T is a transition probability function**
    - $T(s', a, s) = \text{Prob}(s^{t+1} = s' \mid a^t = a, s^t = s)$
  - **Z is an observation function**
    - $Z(o', s', a) = \text{Prob}(o^{t+1} = o' \mid a^t = a, s^{t+1} = s')$
  - **c is a cost function**
    - action  $a$  in state  $s$  incurs some cost,  $c(s, a)$
- **POMDP maintains a *belief* state (vector)**
  - **A probability distribution over the possible states**

# POMDP-based Power Manager

- **Structure of the proposed power manager**

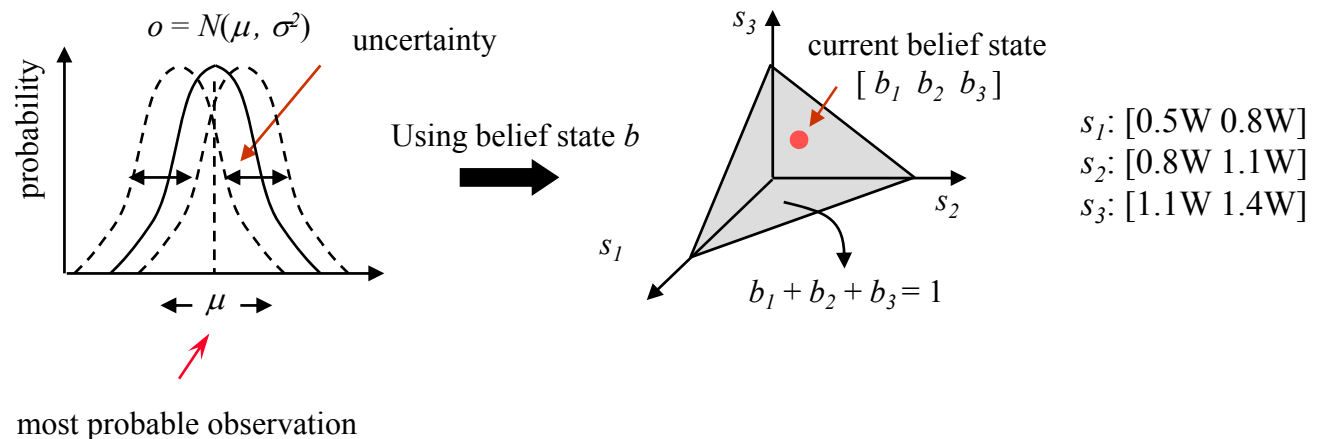




# Power Management Framework (1/2)

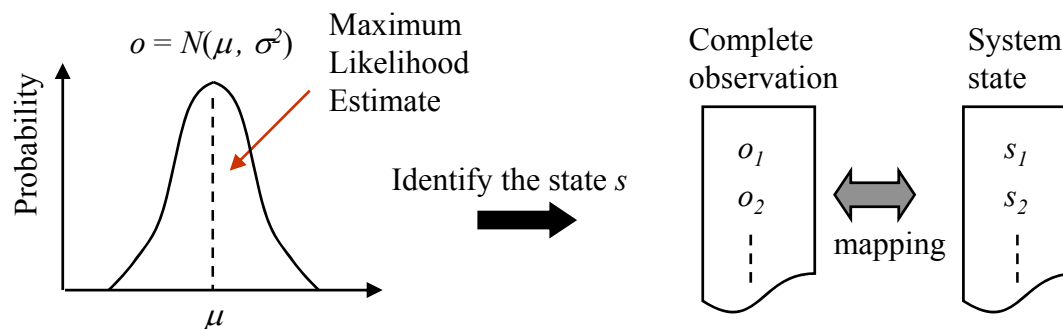
- **Partial observation and its effect on the probability density function**

- **Computing the belief state:** 
$$b^{t+1}(s') = \frac{Z(o', s', a) \sum_s b^t(s) T(s', a, s)}{\sum_{s, s''} Z(o', s'', a) b^t(s) T(s'', a, s)}$$
- **Complexity of computing the belief state grows rapidly with the number of states**
- **Solving a belief-state based DPM problem is quite expensive**



# Power Management Framework (2/2)

- To avoid the complexity of solving the belief-state based DPM problem
  - We adopt a state estimation technique based on the expectation-maximization (EM) algorithm
  - The EM algorithm deals with uncertain information when computing the maximum likelihood estimate (MLE) of the system state
- Forming the complete observation with MLE
  - MLE enables determination of the system state without using belief states



# EM-based State Estimation (1/3)

- **The goal is to obtain estimation of the complete observation by using the EM algorithm**
  - **$o$ : observed data (i.e., noisy measurement)**
  - **$m$ : missing data (i.e., hidden source of variation that affects the power state of the system)**
  - **Together  $o$  and  $m$  constitute the complete data**
  - **EM algorithm finds an observation estimate  $\theta$  that maximizes the complete-data likelihood, which is defined as:**

$$p(o, m | \theta) = p(m | o, \theta) p(o | \theta)$$

- **Identify the system state from the complete data through a pre-defined observation-state mapping table**
  - **The mapping table is obtained by doing extensive simulation at design time**

# Backup slide: EM algorithm (2/3)

- **The EM algorithm iteratively improves an observation estimate  $\theta$  as follows:**  $\theta^{t+1} = \arg \max_{\theta} Q(\theta)$ 
  - $\theta^{t+1}$  : the value that maximizes the conditional expectation of log-likelihood of the complete data given the observed variables
  - $Q(\theta)$  : the expected value of the log-likelihood of complete data
- **We cannot determine the exact value of the log-likelihood since we do not know the complete data**
  - We calculate an expected value of the log-likelihood of complete data for the given values  $o$

$$\begin{aligned} Q(\theta) &= E_m (\log p(o, m | \theta) | o) \\ &= \int_{-\infty}^{\infty} p(m | o) \log p(o, m | \theta) dm \end{aligned}$$

# EM-based State Estimation (3/3)

- The flow of the state estimation by the EM algorithm
  - Expectation step + Maximization step

## Initialization

Initialize parameter (observation estimate):  $\theta$

*until*  $|\theta^{t+1} - \theta| \leq \omega$

## Expectation step

Find expected value of log-likelihood of complete data:  $Q(\theta)$

## Maximization step

Find  $\theta^{t+1}$  which maximize the expected value and set  $\theta = \theta^{t+1}$

## Identifying the state

Identify the system state  $s$  based on the estimate of the complete observation:  $\theta^*$

# Policy Generation (1/2)

- **Policy generation deals with the cost function**
  - A dynamic programming technique is used to solve the problem since it exhibits the property of optimal sub-structure cost

- **The optimum cost is defined as follows:**

- The expected discounted sum of cost that an agent accrues

$$\Psi^*(s) = \min_{\pi} E \left( \sum_{t=0}^{\infty} \gamma^t \cdot c(t) \right)$$

- $\gamma$ : a discount factor,  $0 \leq \gamma < 1$
- $c(t)$ : cost at time  $t$

- **In our problem setup, the cost function is defined as:**

$$\Psi^*(s) = \min_a \left( C(s, a) + \gamma \sum_{s' \in S} T(s', a, s) \Psi^*(s') \right) \quad \forall s \in S$$

# Policy Generation (2/2)

- **Given the cost function, the optimal action can be obtained by**

$$\pi^*(s) = \arg \min_a \left( C(s, a) + \gamma \sum_{s' \in S} T(s', a, s) \Psi^*(s') \right)$$

- **One way to solve Markov decision problem is to use value iteration method**
  - **Value iteration method consists of a recursive update of the value function to choose an action**

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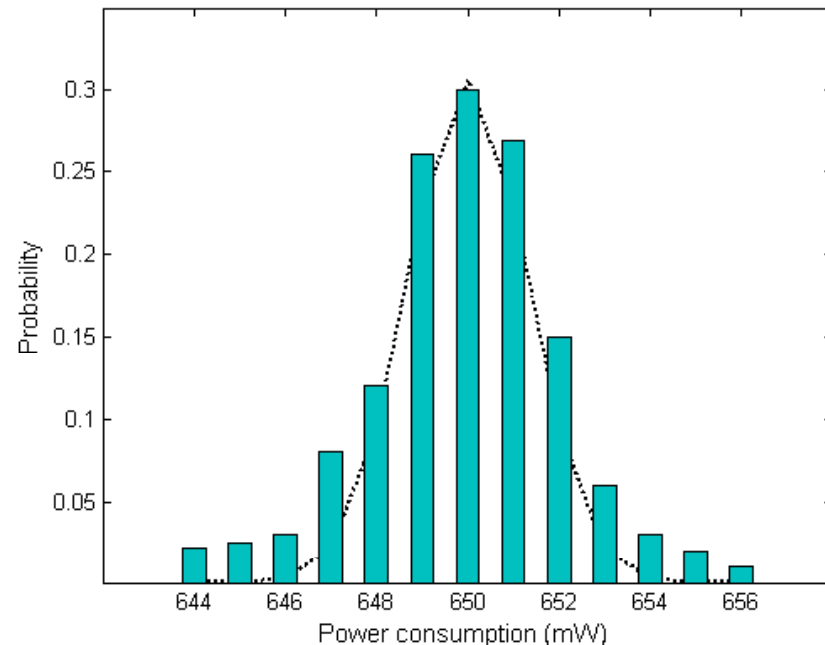
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1: initialize  $\Psi(s)$  arbitrarily
2:   loop until a stopping criterion is met
3:     loop for  $\forall s \in S$ 
4:       loop for  $\forall a \in A$ 
5:          $Q(s, a) = C(s, a) + \gamma \sum_{s' \in S} T(s', a, s) \Psi(s')$ 
6:          $\Psi(s) = \min_a Q(s, a)$ 
7:       end loop
8:     end loop
9:   end loop
```

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**The value iteration algorithm**

# Experimental Results (1/5)

- Apply the proposed DPM technique to a RISC processor realized with 65nm CMOS
- Analyze possible variations of the processor power
  - Vary process corners during simulation
  - Probability density function for power  $\sim N(650, 3.1)$





# Experimental Results (2/5)

- Set the parameter values

State	Description [W]	Obs.	Description [°C]	cost $c(s, a)$ [pJ]		
				$s_1$	$s_2$	$s_3$
$s_1$	[0.5 0.8]	$o_1$	[75 83]	$a_1$	[541 500 470]	
$s_2$	(0.8 1.1]	$o_2$	(83 88]	$a_2$	[465 423 381]	
$s_3$	(1.1 1.4]	$o_3$	(88 95]	$a_3$	[ 450 508 550]	

(  $a_1 = [1.08\text{V}/150\text{MHz}]$ ,  $a_2 = [1.20\text{V}/200\text{MHz}]$ ,  $a_3 = [1.29\text{V}/250\text{MHz}]$  )

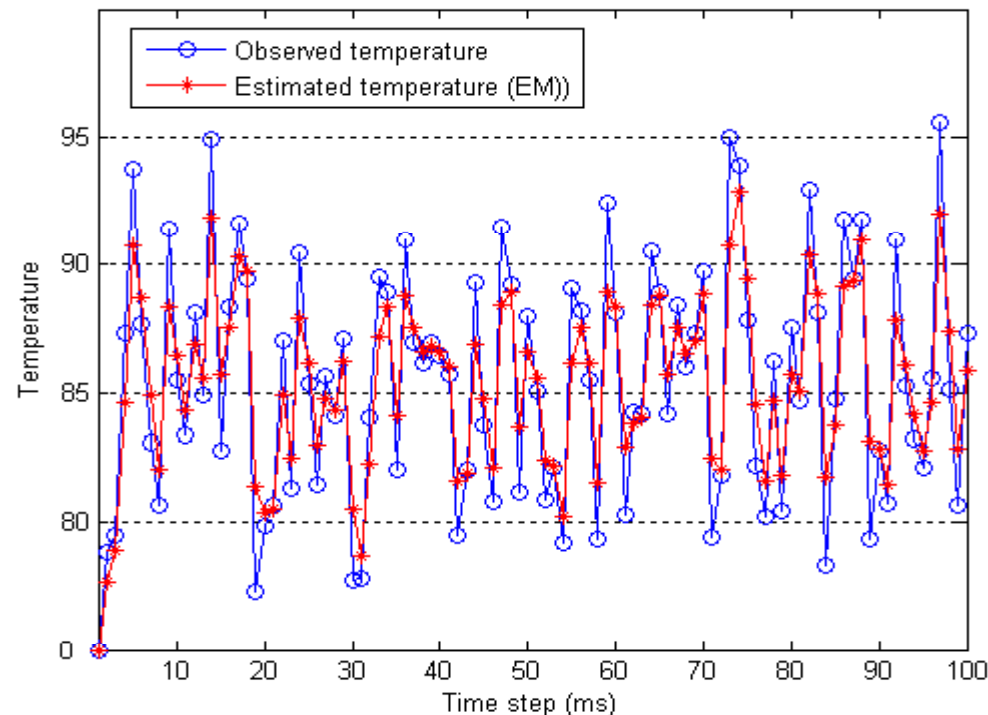
- PBGA package thermal performance data ( $T_A=70$  °C)

Air velocity		$T_{J\_max}$ [°C]	$T_{T\_max}$ [°C]	$\psi_{JT}$ [°C/W]	$\theta_{JA}$ [°C/W]
m/s	ft/min				
0.51	100	107.9	106.7	0.51	16.12
1.02	200	105.3	104.1	0.53	15.62
2.03	300	102.7	101.2	0.65	14.21

- $\psi_{JT}$  : Junction-to-top of package thermal characterization parameter
- $\theta_{JA}$  : Thermal resistance for junction-to-ambient

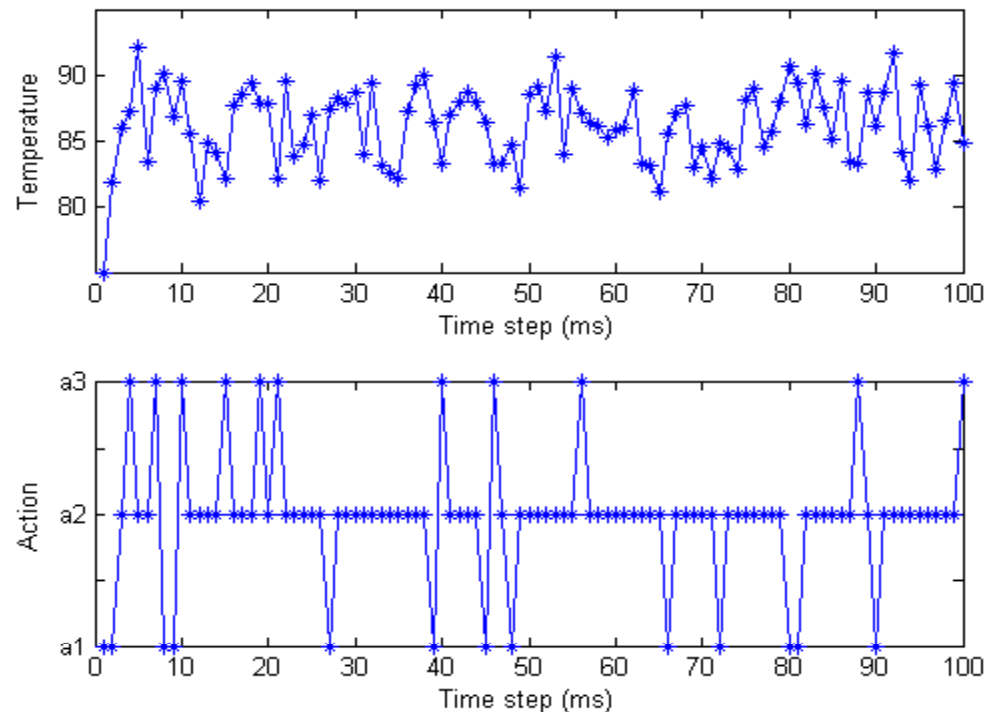
# Experimental Results (3/5)

- Trace of temperatures from the observation and from the MLE estimate
  - Calculate  $T_{chip}$  from  $T_{chip} = T_A + P \cdot (\theta_{JA} - \psi_{JT})$ , where  $P \sim N(P_{sim}, (\Delta P)^2)$



# Experimental Results (4/5)

- **Effectiveness of the policy generation algorithm**
  - **Optimal action is chosen to minimize the cost function by using observations and the EM algorithm to determine the MLE of the system state**



# Experimental Results (5/5)

- **Demonstrate the effectiveness of the DPM technique**
  - Compare with worst and best operating conditions
  - Evaluate how the proposed approach can handle variability
  - The worst case assumption under-estimates the performance and hence results in the largest EDP value for the DPM solution

	Minimum Power	Maximum power	Average Power	Energy (normalized)	EDP (normalized)
<b>Our approach</b>	0.71W	1.12W	0.97W	1.14	1.34
<b>Worst case</b>	0.77W	1.26W	1.02W	1.47	2.30
<b>Best case</b>	0.96W	1.31W	1.15W	1.00	1.00

# Conclusion

- **Proposed a resilient DPM technique which guarantees to select an optimal policy under variability**
- **The proposed DPM framework brings uncertainty to the forefront of decision-making strategy**
- **Being able to handle various sources of uncertainty would improve the accuracy and robustness of the design**
- **The proposed DPM technique ensures energy efficiency, while reducing the uncertain behavior of the system**